

**Search Notes**

Application/Control No.

10/811,932

Examiner

Elias Desta

Applicant(s)/Patent under  
Reexamination

YUE ET AL.

Art Unit

2857

**SEARCHED**

Class	Subclass	Date	Examiner
702	109,127,1 82,189,19 0,193-194,	11/22/2005	E.D
438	5,10,17	11/22/2005	E.D
219	490	11/22/2005	E.D
700	19,28,32	11/22/2005	E.D

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Method of search: EAST, YAHOO, GOOGLE, IEEE Explore, CRC and Semiconductor Publications	11/21/2005	E.D
Consulted: Patrick Assouad, cl 702 au: 2857 (restriction), Nadine Norton, cl 438, au: 1765; Anthony Knight, cl 700, au:2121	11/22/2005	E.D
Text or key word searches: see attachment.	11/22/2005	E.D